TOSHIBA Diodes For Protecting Against ESD Epitaxial Planar Type

DF3A6.8LFU

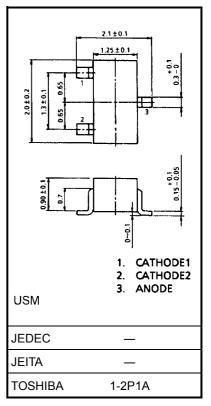
Diodes for Protecting Against ESD

Unit: mm

- Because two devices are mounted on an ultra compact package, it is
 possible to allow reducing the number of the parts and the mounting
 cost.
- Zener voltage correspond to E24 Series.
- Low total capacitance: $C_T = 6.0 \text{ pF (typ.)}$

Maximum Ratings (Ta = 25°C)

| Characteristics | Symbol | Rating | Unit |
|---------------------------|------------------|------------|------|
| Power dissipation | Р | 200 | mW |
| Junction temperature | Tj | 125 | °C |
| Storage temperature range | T _{stg} | -55 to 125 | °C |



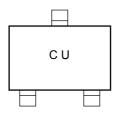
Electrical Characteristics (Ta = 25°C)

| Characteristics | Symbol | Test Condition | Min | Тур. | Max | Unit |
|------------------------|-----------------|---------------------------------|-----|------|-----|------|
| Zener voltage | V_Z | $I_Z = 5 \text{ mA}$ | 6.5 | 6.8 | 7.1 | V |
| Dynamic impedance | Z _Z | $I_Z = 5 \text{ mA}$ | _ | _ | 50 | Ω |
| Knee dynamic impedance | Z _{ZK} | $I_Z = 0.5 \text{ mA}$ | _ | _ | 100 | Ω |
| Reverse current | I _R | V _R = 5 V | _ | _ | 0.5 | μΑ |
| Total capacitance | C _T | V _R = 0 V, f = 1 MHz | _ | 6.0 | _ | pF |

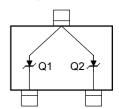
Guaranteed Level of ESD Immunity

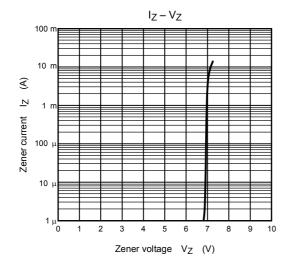
| Test Condition | ESD Immunity Level | | |
|---------------------|--------------------|--|--|
| IEC61000-4-2 | 10.147 | | |
| (contact discharge) | ±8 kV | | |

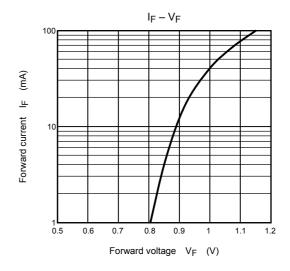
Marking

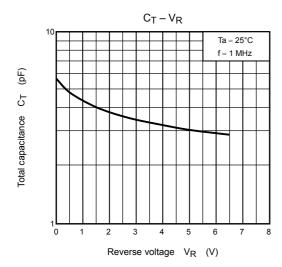


Equivalent Circuit (top view)









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